Search Notes			

Application No.	Applicant(s)
10/706,090	SUGAMOTO ET AL.
Examiner	Art Unit
Granvill D Lee, Jr	2825

SEARCHED				
Class	Subclass	Date	Examiner	
438	745,689	9/1/2004	GL	
438	693,704	9/1/2004	GL	
438	494,498	9/1/2004	GL	
438	504	9/1/2004	GL	
438	734-735	9/1/2004	GL	
216	56,62	9/1/2004	GL	
216	103-109	9/1/2004	GL	
156	345.1	9/1/2004	GL	
156	345.11	9/1/2004	GL	
156	912-915	9/1/2004	GL	
ABose	UPUATED	3/16/2005	GL	
, <u></u>				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
·				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
second solution, oxidative acid, oxidizing agent, crystal defects, secco etch, cleaning, selective etching, HF,defect-free	9/1/2004	GL	
UPDATED SEE EAST	3 <i> 14e 20</i> 05	9	
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